

<b>Notic of Referenc s Cited</b>	Application/Control No. 10/621,746	Applicant(s)/Patent Under Reexamination QIU, WEIGUANG	
	Examiner Thuy V. Tran	Art Unit 2821	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0121865 A1	09-2002	Nakatsuka et al.	315/209.0PZ
	B	US-6,690,121	02-2004	Weindorf, Paul Fredrick Luther	315/247
	C	US-6,566,821	05-2003	Nakatsuka et al.	315/209PZ
	D	US-6,239,558	05-2001	Fujimura et al.	315/307
	E	US-6,016,052	01-2000	Vaughn, Gary	323/355
	F	US-5,923,542	07-1999	Sasaki et al.	363/16
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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